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SHEET 1 OF 1

Form PTO 1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 211648US2S DIV		SERIAL NO. 09/934,827		
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LIST OF REFERENCES CITED BY APPLICANT			APPLICANT .					
			Hideo ANDO, et al.					
			FILING DATE		GROUP			
			August 23, 2001		2615			
				U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE		
RL.	AA	5,771,334	6/23/1998	YAMAUCHI et al.				
W/	AB	5,440,631	8/8/1995	AKIYAMA et al.		_		
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A,	Explanation of Circumstances Concerning Accelerated Examination for Japanese Patent Application No. AD09805001  AW (English Translation).							
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pe	AY	Explanation of Circumstances Concerning Accelerated Examination for Japanese Patent Application No. AD00103787 (English Translation).						
	AZ				Additional References sheet(s) attached			
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*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

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